

PART NUMBER 54LS147BEA-ROCV

Rochester Electronics Manufactured Components

Rochester branded components are manufactured using either die/wafers purchased from the original suppliers or Rochester wafers recreated from the original IP. All re-creations are done with the approval of the Original Component Manufacturer. (OCM)

Parts are tested using original factory test programs or Rochester developed test solutions to guarantee product meets or exceeds the OCM data sheet.

Quality Overview

- ISO-9001
- AS9120 certification
- Qualified Manufacturers List (QML) MIL-PRF-38535
 - Class Q Military
 - Class V Space Level

Qualified Suppliers List of Distributors (QSLD)

 Rochester is a critical supplier to DLA and meets all industry and DLA standards.

Rochester Electronics, LLC is committed to supplying products that satisfy customer expectations for quality and are equal to those originally supplied by industry manufacturers.

The original manufacturer's datasheet accompanying this document reflects the performance and specifications of the Rochester manufactured version of this device. Rochester Electronics guarantees the performance of its semiconductor products to the original OCM specifications. 'Typical' values are for reference purposes only. Certain minimum or maximum ratings may be based on product characterization, design, simulation, or sample testing.



54LS147

10-to-4-Line Priority Encoder

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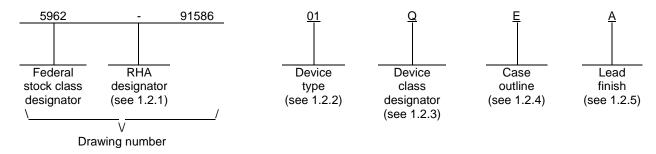
REVISIONS								
LTR	DESCRIPTION	DATE (YR-MO-DA)	APPROVED					
Α	Added case outline 2. Updated Table I Vonconditions. Editorial changes throughout	99-07-15	Ray L. Monnin					
В	Update to current requirements. Editorial changes throughout. – gap	06-08-02	Ray L. Monnin					
С	Remove class M references. Update drawing to current MIL-PRF-38535 requirements jt	16-12-16	Charles F. Saffle					



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SHEET																			
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THIS DRAWING IS AVAILABLE FOR USE BY ALL DEPARTMENTS AND AGENCIES OF THE APPROVED BY Ray Monnin DRAWING APPROVAL DATE				OATE		SCI	MICROCIRCUIT, DIGITAL, LOW POWER SCHOTTKY TTL, 10-LINE-TO-4-LINE PRIORITY ENCODER, MONOLITHIC SILICON						′						
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1. SCOPE

- 1.1 <u>Scope</u>. This drawing documents two product assurance class levels consisting of high reliability (device class Q) and space application (device class V). A choice of case outlines and lead finishes are available and are reflected in the Part or Identifying Number (PIN). When available, a choice of Radiation Hardness Assurance (RHA) levels is reflected in the PIN.
 - 1.2 PIN. The PIN is as shown in the following example:



- 1.2.1 RHA designator. Device classes Q and V RHA marked devices meet the MIL-PRF-38535 specified RHA levels and are marked with the appropriate RHA designator. A dash (-) indicates a non-RHA device.
 - 1.2.2 <u>Device types</u>. The device type identify the circuit function as follows:

Device type	Generic number	<u>Circuit function</u>
01	54LS147	10-line-to-4-line priority encoder

1.2.3 <u>Device class designator</u>. The device class designator is a single letter identifying the product assurance level as follows:

Device class

Device requirements documentation

Q or V

Certification and qualification to MIL-PRF-38535

1.2.4 <u>Case outlines</u>. The case outlines are as designated in MIL-STD-1835 and as follows:

Outline letter	Descriptive designator	<u>Terminals</u>	Package style
E	GDIP1-T16 or CDIP2-T16	16	Dual-in-line Package
F	GDFP2-F16 or CDFP3-F16	16	Flat Package
2	CQCC1-N20 or CQCC2-N20	20	Square leadless chip carrier Package

1.2.5 Lead finish. The lead finish is as specified in MIL-PRF-38535 for device classes Q and V.

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1.3 Absolute maximum ratings. 1/

Supply voltage (V _{CC})	+7.0 V dc
Maximum power dissipation (P _D) <u>2</u> /	140 mW
Input voltage (V _I)	+7.0 V dc
Storage temperature range	-65°C to +150°C
Thermal resistance, junction-to-case (θ_{JC})	See MIL-STD-1835
Junction temperature (T _J)	+175°C
Case operating temperature range (T _C)	-55°C to +125°C

1.4 Recommended operating conditions.

Supply voltage range (V _{CC})	4.5 V dc to 5.5 V dc
High-level output current (I _{OH})	-0.4 mA maximum
Low-level output current (IoL)	4 mA maximum
Case operating temperature (T _C)	-55°C to +125°C

2. APPLICABLE DOCUMENTS

2.1 <u>Government specification, standards, and handbooks</u>. The following specification, standards, and handbooks form a part of this drawing to the extent specified herein. Unless otherwise specified, the issues of these documents are those cited in the solicitation or contract.

DEPARTMENT OF DEFENSE SPECIFICATION

MIL-PRF-38535 - Integrated Circuits, Manufacturing, General Specification for.

DEPARTMENT OF DEFENSE STANDARDS

MIL-STD-883 - Test Method Standard Microcircuits.

MIL-STD-1835 - Interface Standard Electronic Component Case Outlines.

DEPARTMENT OF DEFENSE HANDBOOKS

MIL-HDBK-103 - List of Standard Microcircuit Drawings.

MIL-HDBK-780 - Standard Microcircuit Drawings.

(Copies of these documents are available online at http://quicksearch.dla.mil or from the Standardization Document Order Desk, 700 Robbins Avenue, Building 4D, Philadelphia, PA 19111-5094.)

2.2 <u>Order of precedence</u>. In the event of a conflict between the text of this drawing and the references cited herein, the text of this drawing takes precedence. Nothing in this document, however, supersedes applicable laws and regulations unless a specific exemption has been obtained.

^{2/} P_D is defined as V_{CC} x I_{CC}.

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^{1/} Stresses above the absolute maximum rating may cause permanent damage to the device. Extended operation at the maximum levels may degrade performance and affect reliability.

3. REQUIREMENTS

- 3.1 <u>Item requirements</u>. The individual item requirements for device classes Q and V shall be in accordance with MIL-PRF-38535 as specified herein, or as modified in the device manufacturer's Quality Management (QM) plan. The modification in the QM plan shall not affect the form, fit, or function as described herein.
- 3.2 <u>Design, construction, and physical dimensions</u>. The design, construction, and physical dimensions shall be as specified in MIL-PRF-38535 and herein for device classes Q and V.
 - 3.2.1 Case outlines. The case outlines shall be in accordance with 1.2.4 herein.
 - 3.2.2 Terminal connections. The terminal connections shall be as specified on figure 1.
 - 3.2.3 Truth tables. The truth tables shall be as specified on figure 2.
 - 3.2.4 Logic diagram. The logic diagram shall be as specified on figure 3.
 - 3.2.5 Test circuit and timing waveforms. The test circuit and timing waveforms shall be as specified on figure 4.
- 3.3 <u>Electrical performance characteristics and postirradiation parameter limits</u>. Unless otherwise specified herein, the electrical performance characteristics and postirradiation parameter limits are as specified in table I and shall apply over the full case operating temperature range.
- 3.4 <u>Electrical test requirements</u>. The electrical test requirements shall be the subgroups specified in table II. The electrical tests for each subgroup are defined in table I.
- 3.5 <u>Marking</u>. The part shall be marked with the PIN listed in 1.2 herein. In addition, the manufacturer's PIN may also be marked. For packages where marking of the entire SMD PIN number is not feasible due to space limitations, the manufacturer has the option of not marking the "5962-" on the device. For RHA product using this option, the RHA designator shall still be marked. Marking for device classes Q and V shall be in accordance with MIL-PRF-38535.
- 3.5.1 <u>Certification/compliance mark</u>. The certification mark for device classes Q and V shall be a "QML" or "Q" as required in MIL-PRF-38535.
- 3.6 <u>Certificate of compliance</u>. For device classes Q and V, a certificate of compliance shall be required from a QML-38535 listed manufacturer in order to supply to the requirements of this drawing (see 6.6.1 herein). The certificate of compliance submitted to DLA Land and Maritime-VA prior to listing as an approved source of supply for this drawing shall affirm that the manufacturer's product meets, for device classes Q and V, the requirements of MIL-PRF-38535 and herein.
- 3.7 <u>Certificate of conformance</u>. A certificate of conformance as required for device classes Q and V in MIL-PRF-38535 shall be provided with each lot of microcircuits delivered to this drawing.

STANDARD
MICROCIRCUIT DRAWING

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TABLE I. Electrical performance characteristics.

Test	Symbol	Conditions -55°C ≤ T _C ≤ +125°C	Group A subgroups	Device type	Lir	Unit	
		unless otherwise specified			Min	Max	
High-level input voltage	V _{IH}		1, 2, 3	All	2.0		V
Low-level input voltage	V _{IL}		1, 2, 3	All		0.7	V
Input clamp voltage	VIK	V _{CC} = 4.5 V, I _I = -18 mA	1, 2, 3	All		-1.5	V
High-level output voltage	V _{OH}	V _{CC} = 4.5 V, V _{IH} = 2.0 V, I _{OH} = -0.4 mA, V _{IL} = 0.7 V	1, 2, 3	All	2.5		V
Low-level output voltage	V _{OL}	$V_{CC} = 4.5 \text{ V}, V_{IH} = 2.0 \text{ V},$ $V_{IL} = 0.7 \text{ V}, I_{OL} = 4 \text{ mA}$	1, 2, 3	All		0.4	V
Input current at maximum input voltage	II	V _{CC} = 5.5 V, V _I = 7.0 V	1, 2, 3	All		0.1	mA
High-level input current	Iн	V _{CC} = 5.5 V, V _I = 2.7 V	1, 2, 3	All		20	μА
Low-level input current	I _{IL}	V _{CC} = 5.5 V, V _I = 0.4 V	1, 2, 3	All		-0.4	mA
Short circuit current	Ios	V _{CC} = 5.5 V	1, 2, 3	All	-20	-100	mA
Supply current	Icc	V _{CC} = 5.5 V. All inputs and outputs open, except input 7 at GND	1, 2, 3	All		20	mA
Functional test		See 4.4.1b	7, 8A, 8B	All			
Propagation delay time, low- to-high level output, from any input to any output	tpLH	C_L = 15 pF R_L = 2000 Ω , In-phase output	9	All		18	ns
Propagation delay time, high- to-low level output, from any input to any output	tPHL	V _{CC} = 5.0 V, T _C = 25°C 2/	9	All		18	ns
Propagation delay time, low- to-high level output, from any input to any output	tpLH	C_L = 15 pF R_L = 2000 Ω , Out-of-phase output	9	All		33	ns
Propagation delay time, high-to-low level output, from any input to any output	tpHL	$V_{CC} = 5.0 \text{ V}, T_{C} = 25^{\circ}\text{C}$ 2/	9	All		23	ns

For negative and positive voltage and current values, the sign designates the potential difference to GND and the direction of current flow, respectively, and the absolute value of the magnitude, not the sign, is relative to the minimum and maximum limits, as applicable, listed herein. Load circuits and voltage waveforms are shown in Figure 4.

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Device type		01			
Case outlines	E	F	2		
Terminal number	Т	Terminal symbol			
1	4	4	NC		
2	5	5	4		
3	6	6	5		
4	7	7	6		
5	8	8	7		
6	С	С	NC		
7	В	В	8		
8	GND	GND	С		
9	Α	Α	В		
10	9	9	GND		
11	1	1	NC		
12	2	2	Α		
13	3	3	9		
14	D	D	1		
15	NC	NC	2		
16	Vcc	Vcc	NC		
17			3		
18			D		
19			NC		
20			Vcc		

FIGURE 1. <u>Terminal connections</u>.

			I	NPUTS	3					OUTI	PUTS	
1	2	3	4	5	6	7	8	9	D	С	В	Α
Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н
Х	Χ	Χ	Χ	Χ	Χ	Χ	Χ	L	L	Н	Н	L
Х	Χ	Χ	Χ	Χ	Χ	Χ	L	Н	L	Н	Н	Н
Χ	X	Х	X	Χ	Χ	L	Н	Н	Н	L	L	L
Χ	X	Х	X	Χ	L	Н	Н	Н	Н	L	L	Н
Х	Χ	Χ	Χ	L	Н	Н	Н	Н	Н	L	Н	L
Х	Χ	Χ	L	Н	Н	Н	Н	Н	Н	L	Н	Н
Χ	X	L	Н	Н	Н	Н	Н	Н	Н	Н	L	L
Х	L	Н	Н	Н	Н	Н	Н	Н	Н	Н	L	Н
L	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	L

H = high logic level L = low logic level X = irrelevant

FIGURE 2. Truth table.

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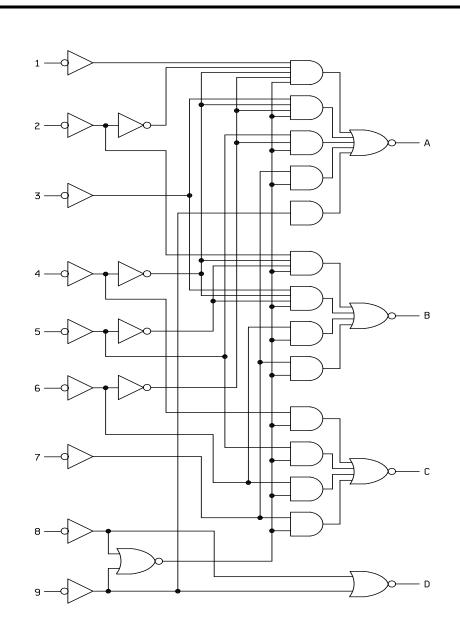
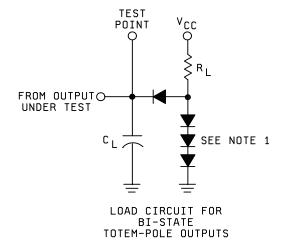
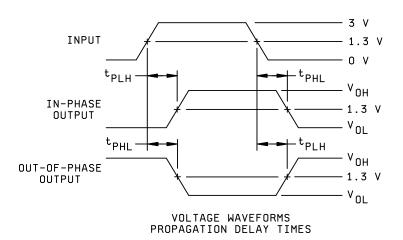


FIGURE 3. Logic diagram.

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NOTES:

- 1. All diodes are 1N916 or 1N3064.
- 2. C_L includes probe and jig capacitance.

FIGURE 4. Test circuit and timing waveforms.

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4. VERIFICATION

- 4.1 <u>Sampling and inspection</u>. For device classes Q and V, sampling and inspection procedures shall be in accordance with MIL-PRF-38535 or as modified in the device manufacturer's Quality Management (QM) plan. The modification in the QM plan shall not affect the form, fit, or function as described herein.
- 4.2 <u>Screening</u>. For device classes Q and V, screening shall be in accordance with MIL-PRF-38535, and shall be conducted on all devices prior to qualification and technology conformance inspection.
 - 4.2.1 Additional criteria for device classes Q and V.
 - a. The burn-in test duration, test condition and test temperature, or approved alternatives shall be as specified in the device manufacturer's QM plan in accordance with MIL-PRF-38535. The burn-in test circuit shall be maintained under document revision level control of the device manufacturer's Technology Review Board (TRB) in accordance with MIL-PRF-38535 and shall be made available to the acquiring or preparing activity upon request. The test circuit shall specify the inputs, outputs, biases, and power dissipation, as applicable, in accordance with the intent specified in method 1015 of MIL-STD-883.
 - b. Interim and final electrical test parameters shall be as specified in table II herein.
 - Additional screening for device class V beyond the requirements of device class Q shall be as specified in MIL-PRF-38535, appendix B.
- 4.3 <u>Qualification inspection for device classes Q and V</u>. Qualification inspection for device classes Q and V shall be in accordance with MIL-PRF-38535. Inspections to be performed shall be those specified in MIL-PRF-38535 and herein for groups A, B, C, D, and E inspections (see 4.4.1 through 4.4.4).
- 4.4 <u>Conformance inspection</u>. Technology conformance inspection for classes Q and V shall be in accordance with MIL-PRF-38535 including groups A, B, C, D, and E inspections, and as specified herein.
 - 4.4.1 Group A inspection.
 - a. Tests shall be as specified in table II herein.
 - b. For device classes Q and V, subgroups 7 and 8 shall include verifying the functionally of the device.

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TABLE II. Electrical test requirements.

Test requirements	Subgr	oups
	(in accorda	ance with
	MIL-PRF-385	535, table III)
	Device	Device
	class Q	class V
Interim electrical		
parameters (see 4.2)		
Final electrical	<u>1</u> / 1, 2, 3, 7,	<u>2</u> / 1, 2, 3, 7,
parameters (see 4.2)	8A, 8B, 9	8A, 8B, 9
Group A test	1, 2, 3, 7,	1, 2, 3, 7,
requirements (see 4.4)	8A, 8B, 9	8A, 8B, 9
Group C end-point electrical	1, 2, 3	1, 2, 3
parameters (see 4.4)		
Group D end-point electrical	1, 2, 3	1, 2, 3
parameters (see 4.4)		
Group E end-point electrical	1, 7, 9	1, 7, 9
parameters (see 4.4)		

- 1/ PDA applies to subgroup 1.
- 2/ PDA applies to subgroups 1 and 7.
- 4.4.2 Group C inspection. The group C inspection end-point electrical parameters shall be as specified in table II herein.
- 4.4.2.1 Additional criteria for device classes Q and V. The steady-state life test duration, test condition and test temperature, or approved alternatives shall be as specified in the device manufacturer's QM plan in accordance with MIL-PRF-38535. The test circuit shall be maintained under document revision level control by the device manufacturer's TRB in accordance with MIL-PRF-38535 and shall be made available to the acquiring or preparing activity upon request. The test circuit shall specify the inputs, outputs, biases, and power dissipation, as applicable, in accordance with the intent specified in method 1005 of MIL-STD-883.
 - 4.4.3 Group D inspection. The group D inspection end-point electrical parameters shall be as specified in table II herein.
- 4.4.4 <u>Group E inspection</u>. Group E inspection is required only for parts intended to be marked as radiation hardness assured (see 3.5 herein).
 - a. End-point electrical parameters shall be as specified in table II herein.
 - b. For device classes Q and V, the devices or test vehicle shall be subjected to radiation hardness assured tests as specified in MIL-PRF-38535 for the RHA level being tested. All device classes must meet the postirradiation end-point electrical parameter limits as defined in table I at T_A = +25°C ±5°C, after exposure, to the subgroups specified in table II herein.
 - 5. PACKAGING
- 5.1 <u>Packaging requirements</u>. The requirements for packaging shall be in accordance with MIL-PRF-38535 for device classes Q and V.

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6. NOTES

- 6.1 <u>Intended use</u>. Microcircuits conforming to this drawing are intended for use for Government microcircuit applications (original equipment), design applications, and logistics purposes.
- 6.1.1 <u>Replaceability</u>. Microcircuits covered by this drawing will replace the same generic device covered by a contractor prepared specification or drawing.
- 6.2 <u>Configuration control of SMD's</u>. All proposed changes to existing SMD's will be coordinated with the users of record for the individual documents. This coordination will be accomplished using DD Form 1692, Engineering Change Proposal.
- 6.3 <u>Record of users</u>. Military and industrial users should inform DLA Land and Maritime when a system application requires configuration control and which SMD's are applicable to that system. DLA Land and Maritime will maintain a record of users and this list will be used for coordination and distribution of changes to the drawings. Users of drawings covering microelectronic devices (FSC 5962) should contact DLA Land and Maritime-VA, telephone (614) 692-8108.
- 6.4 <u>Comments</u>. Comments on this drawing should be directed to DLA Land and Maritime-VA, Columbus, Ohio 43218-3990, or telephone (614) 692-0540.
- 6.5 <u>Abbreviations, symbols, and definitions</u>. The abbreviations, symbols, and definitions used herein are defined in MIL-PRF-38535 and MIL-HDBK-1331.
 - 6.6 Sources of supply.
- 6.6.1 <u>Sources of supply for device classes Q and V</u>. Sources of supply for device classes Q and V are listed in MIL-HDBK-103 and QML-38535. The vendors listed in MIL-HDBK-103 and QML-38535 have submitted a certificate of compliance (see 3.6 herein) to DLA Land and Maritime-VA and have agreed to this drawing.

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STANDARD MICROCIRCUIT DRAWING BULLETIN

DATE: 16-12-16

Approved sources of supply for SMD 5962-91586 are listed below for immediate acquisition information only and shall be added to MIL-HDBK-103 and QML-38535 during the next revision. MIL-HDBK-103 and QML-38535 will be revised to include the addition or deletion of sources. The vendors listed below have agreed to this drawing and a certificate of compliance has been submitted to and accepted by DLA Land and Maritime-VA. This information bulletin is superseded by the next dated revision of MIL-HDBK-103 and QML-38535. DLA Land and Maritime maintains an online database of all current sources of supply at https://landandmaritimeapps.dla.mii/Programs/Smcr/.

Standard microcircuit drawing PIN <u>1</u> /	Vendor CAGE number	Vendor similar PIN <u>2</u> /
5962-9158601QEA	3V146	54LS147/BEA
	0DKS7	GEM31201QEA
5962-9158601QEC	0DKS7	GEM31201QEC
5962-9158601QFA	3V146	54LS147/BFA
	0DKS7	GEM31201QFA
5962-9158601QFC	0DKS7	GEM31201QFC
5962-9158601Q2A	3V146	54LS147/B2A
	0DKS7	GEM31201Q2A
5962-9158601Q2C	0DKS7	GEM31201Q2C

- 1/ The lead finish shown for each PIN representing a hermetic package is the most readily available from the manufacturer listed for that part. If the desired lead finish is not listed contact the vendor to determine its availability.
- <u>2/</u> <u>Caution</u>. Do not use this number for item acquisition. Items acquired to this number may not satisfy the performance requirements of this drawing.

Vendor CAGE number	Vendor name and address
3V146	Rochester Electronics Inc. 16 Malcolm Hoyt Drive Newburyport, MA 01950
0DKS7	SRI International 201 Washington Road Princeton, NJ 08540-6449

The information contained herein is disseminated for convenience only and the Government assumes no liability whatsoever for any inaccuracies in the information bulletin.